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| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination ERDELY ET AL. | |
| | | Examiner BINH K. TIEU | Art Unit 2614 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| * | A | US-4,759,059 | 07-1988 | Christensen, Larry B. | 379/161 |
| * | B | US-4,987,586 | 01-1991 | Gross et al. | 379/93.09 |
| * | C | US-5,003,580 | 03-1991 | Duong et al. | 379/93.09 |
| * | D | US-5,550,901 | 08-1996 | Williams, Arthur B. | 379/93.05 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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